FORM PTO-1449	SERIAL NO. 10/668,740	ATTORNEY DOCKET NO. SVL920030067US1
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION	FILING DATE September 23, 2003	GROUP ART UNIT 2179
DISCLOSURE STATEMENT  (use several sheets if necessary)	APPLICANT(S): Shyh-Mei F. Ho et al.	

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